

R1RP0416DI Series

Wide Temperature Version 4M High Speed SRAM (256-kword × 16-bit) R10DS0285EJ0100 Rev.1.00 Nov.18.19

Description

The R1RP0416DI Series is a 4-Mbit high speed static RAM organized 256-k word \times 16-bit. It has realized high speed access time by employing CMOS process (6-transistor memory cell) and high speed circuit designing technology. It is most appropriate for the application which requires high speed, high density memory and wide bit width configuration, such as cache and buffer memory in system. It is packaged in 400-mil 44-pin plastic SOJ and 400-mil 44-pin plastic TSOPII.

Features

Single 5.0V supply: 5.0V ± 10%Access time: 10ns /12ns (max)

Completely static memory

No clock or timing strobe required

Equal access and cycle times

• Directly TTL compatible

— All inputs and outputs

• Operating current: 170mA / 160mA (max)

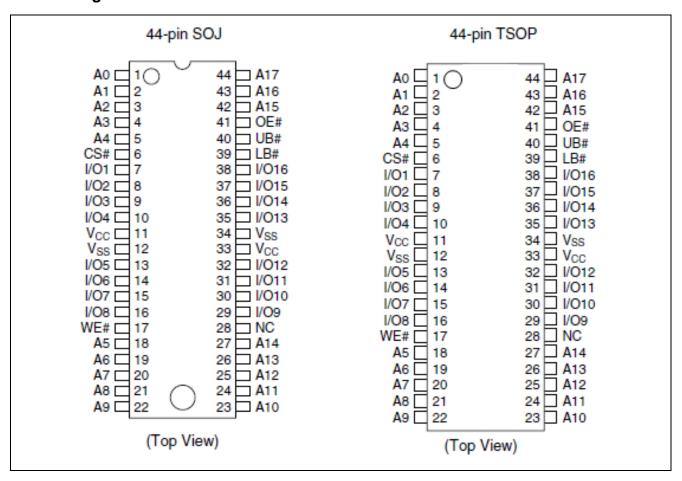
TTL standby current: 40mA (max)
CMOS standby current: 5mA (max)
Center Vcc and Vss type pin out

• Temperature range: -40 to +85°C

Ordering Information

Type No.	Access time	Package
R1RP0416DGE-2PI	12ns	400-mil 44-pin plastic SOJ
R1RP0416DSB-0PI	10ns	400 mil 44 nin plantia TSORII
R1RP0416DSB-2PI	12ns	400-mil 44-pin plastic TSOPII

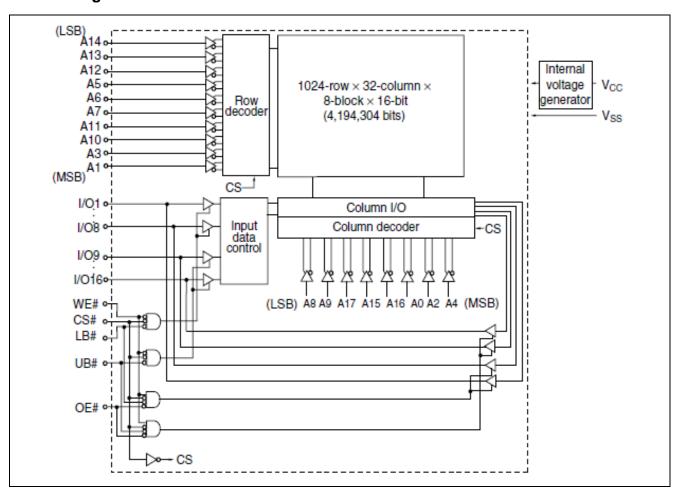
Pin Arrangement



Pin Description

Pin name	Function
A0 to A17	Address input
I/O1 to I/O16	Data input/output
CS#	Chip select
OE#	Output enable
WE#	Write enable
UB#	Upper byte select
LB#	Lower byte select
Vcc	Power supply
Vss	Ground
NC	No connection

Block Diagram



Operation Table

CS#	OE#	WE#	LB#	UB#	Mode	Vcc current	I/O1-I/O8	I/O9-I/O16	Ref. cycle
Н	×	×	×	×	Standby	I _{SB} , I _{SB1}	High-Z	High-Z	_
L	Н	Н	×	×	Output disable	Icc	High-Z	High-Z	_
L	L	Н	L	L	Read	Icc	Output	Output	Read cycle
L	L	Н	L	Н	Lower byte read	Icc	Output	High-Z	Read cycle
L	L	Н	Н	L	Upper byte read	Icc	High-Z	Output	Read cycle
L	L	Н	Н	Н	_	Icc	High-Z	High-Z	_
L	×	L	L	L	Write	Icc	Input	Input	Write cycle
L	×	L	L	Н	Lower byte write	Icc	Input	High-Z	Write cycle
L	×	L	Н	L	Upper byte write	Icc	High-Z	Input	Write cycle
L	×	L	Н	Н		Icc	High-Z	High-Z	_

Note: H: V_{IH} , L: V_{IL} , \times : V_{IH} or V_{IL}

Absolute Maximum Ratings

Parameter	Symbol	Value	Unit
Supply voltage relative to V _{SS}	Vcc	−0.5 to +7.0	V
Voltage on any pin relative to Vss	VT	-0.5*1 to V _{CC} + 0.5*2	V
Power dissipation	PT	1.0	W
Operating temperature	Topr	-40 to +85	°C
Storage temperature	Tstg	−55 to +125	°C
Storage temperature under bias	Tbias	-40 to +85	°C

Notes: 1. V_T (min) = -2.0 V for pulse width (under shoot) \leq 6 ns.

2. V_T (max) = V_{CC} + 2.0 V for pulse width (over shoot) \leq 6 ns.

Recommended DC Operating Conditions

 $(Ta = -40 \text{ to } +85^{\circ}C)$

				,	,
Parameter	Symbol	Min	Тур	Max	Unit
Supply voltage	Vcc*3	4.5	5.0	5.5	V
	Vss*4	0	0	0	V
Input voltage	ViH	2.2	_	Vcc + 0.5*2	V
	VIL	-0.5* ¹	_	0.8	V

Notes: 1. V_{IL} (min) = -2.0V for pulse width (under shoot) \leq 6ns.

- 2. V_{IH} (max) = V_{CC} + 2.0V for pulse width (over shoot) \leq 6ns.
- 3. The supply voltage with all V_{CC} pins must be on the same level.
- 4. The supply voltage with all Vss pins must be on the same level.

DC Characteristics

(Ta = -40 to +85°C, Vcc = 5.0V \pm 10%, Vss = 0V)

Parame	Parameter		Min	Max	Unit	Test conditions
Input leakage curre	ent	I _{LI}	_	2	μΑ	$V_{IN} = V_{SS}$ to V_{CC}
Output leakage cur	rent	I _{LO}	_	2	μΑ	$V_{IN} = V_{SS}$ to V_{CC}
Operating power 10ns cycle		Icc	_	170	mA	Min cycle
supply current	12ns cycle	Icc	_	160	mA	$-CS\# = V_{IL}, I_{OUT} = 0mA$ Other inputs = V_{IH}/V_{IL}
Standby power sup	andby power supply current		_	40	mA	Min cycle, CS# = V _{IH} , Other inputs = V _{IH} /V _{IL}
		I _{SB1}	_	5	mA	$ \begin{split} &f = 0 MHz \\ &V_{CC} \geq CS\# \geq V_{CC} - 0.2V, \\ &(1) \ 0V \leq V_{IN} \leq 0.2V \ or \\ &(2) \ V_{CC} \geq V_{IN} \geq V_{CC} - 0.2V \end{split} $
Output voltage		Vol	_	0.4	V	I _{OL} = 8mA
			2.4	_	V	I _{OH} = -4mA

Capacitance

 $(Ta = +25^{\circ}C, f = 1.0MHz)$

Parameter	Symbol	Min	Max	Unit	Test conditions
Input capacitance*1	CIN	_	6	pF	V _{IN} = 0V
Input/output capacitance*1	Cı/o		8	pF	V _{I/O} = 0V

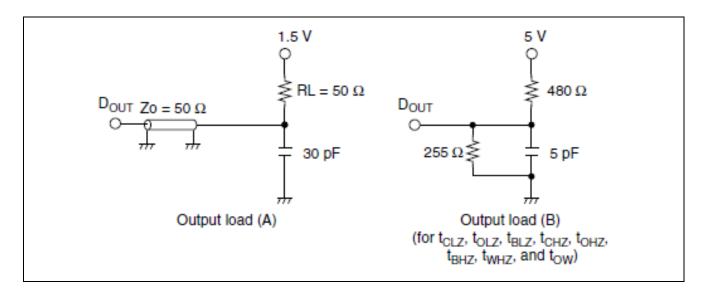
Note: 1. This parameter is sampled and not 100% tested.

AC Characteristics

Test Conditions (Ta = -40 to $+85^{\circ}$ C, $V_{CC} = 5.0$ V $\pm 10\%$, unless otherwise noted.)

Input pulse levels: 3.0V/0.0VInput rise and fall time: 3ns

Input and output timing reference levels: 1.5V
Output load: See figures (Including scope and jig)



Read Cycle

		R1RP0416DI					
		10ns \	/ersion	12ns \	/ersion		
Parameter	Symbol	Min	Max	Min	Max	Unit	Notes
Read cycle time	t _{RC}	10	_	12	_	ns	
Address access time	t _{AA}	_	10	_	12	ns	
Chip select access time	t _{ACS}	_	10	_	12	ns	
Output enable to output valid	toe	_	5	_	6	ns	
Byte select to output valid	t _{BA}	_	5	_	6	ns	
Output hold from address change	tон	3	_	3	_	ns	
Chip select to output in low-Z	tclz	3	_	3	_	ns	1
Output enable to output in low-Z	tolz	0	_	0	_	ns	1
Byte select to output in low-Z	t _{BLZ}	0	_	0	_	ns	1
Chip deselect to output in high-Z	t _{CHZ}	_	5	_	6	ns	1
Output disable to output in high-Z t _{OHZ}		_	5	_	6	ns	1
Byte deselect to output in high-Z	t _{BHZ}	_	5	_	6	ns	1

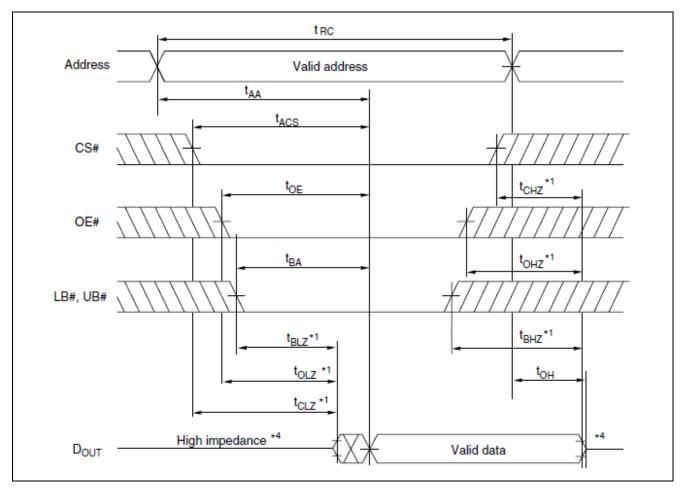
Write Cycle

		R1RP0416DI					
		10ns \	/ersion 12ns \		/ersion		
Parameter	Symbol	Min	Max	Min	Max	Unit	Notes
Write cycle time	t _{WC}	10	_	12	_	ns	
Address valid to end of write	t _{AW}	7	_	8	_	ns	
Chip select to end of write	tcw	7	_	8	_	ns	8
Write pulse width	twp	7	_	8	_	ns	7
Byte select to end of write	t _{BW}	7	_	8	_	ns	
Address setup time tas		0	_	0	_	ns	5
Write recovery time	twR	0	_	0	_	ns	6
Data to write time overlap	t _{DW}	5	_	6	_	ns	
Data hold from write time	tон	0	_	0	_	ns	
Write disable to output in low-Z	tow	3	_	3	_	ns	1
Output disable to output in high-Z t _{OHZ}		_	5	_	6	ns	1
Write enable to output in high-Z	t _{WHZ}	_	5	_	6	ns	1

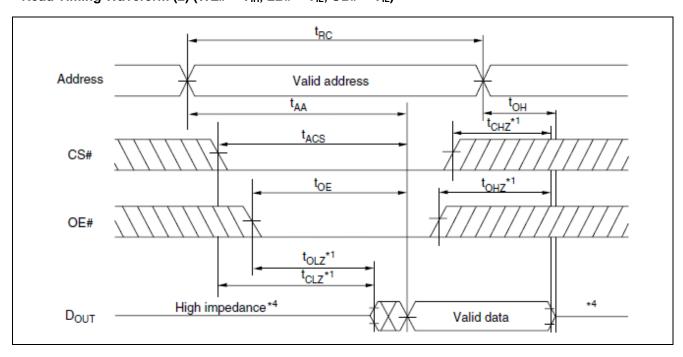
- Notes: 1. Transition is measured $\pm 200 \text{mV}$ from steady voltage with output load (B). This parameter is sampled and not 100% tested.
 - 2. If the CS# or LB# or UB# low transition occurs simultaneously with the WE# low transition or after the WE# transition, output remains a high impedance state.
 - 3. WE# and/or CS# must be high during address transition time.
 - 4. If CS#, OE#, LB# and UB# are low during this period, I/O pins are in the output state. Then the data input signals of opposite phase to the outputs must not be applied to them.
 - 5. t_{AS} is measured from the latest address transition to the latest of CS#, WE#, LB# or UB# going low.
 - 6. twn is measured from the earliest of CS#, WE#, LB# or UB# going high to the first address transition.
 - 7. A write occurs during the overlap of a low CS#, a low WE# and a low LB# or a low UB# (twp). A write begins at the latest transition among CS# going low, WE# going low and LB# going low or UB# going low. A write ends at the earliest transition among CS# going high, WE# going high and LB# going high or UB# going high.
 - 8. tcw is measured from the later of CS# going low to the end of write.

Timing Waveforms

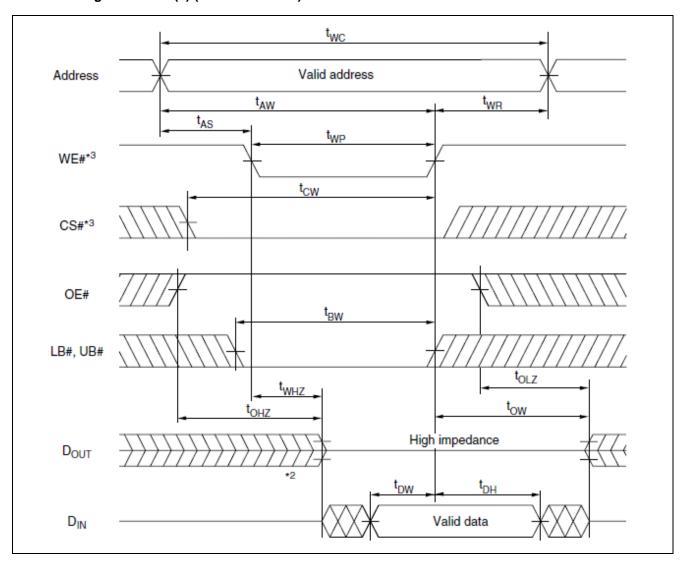
Read Timing Waveform (1) (WE# = V_{IH})



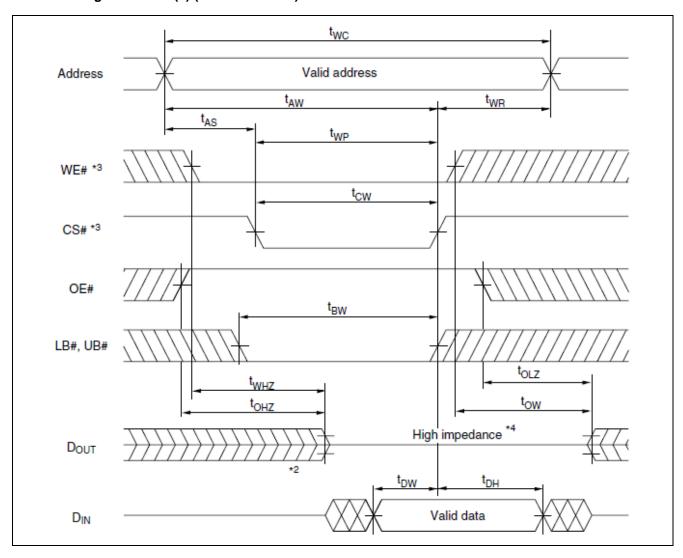
Read Timing Waveform (2) (WE# = V_{IH} , LB# = V_{IL} , UB# = V_{IL})



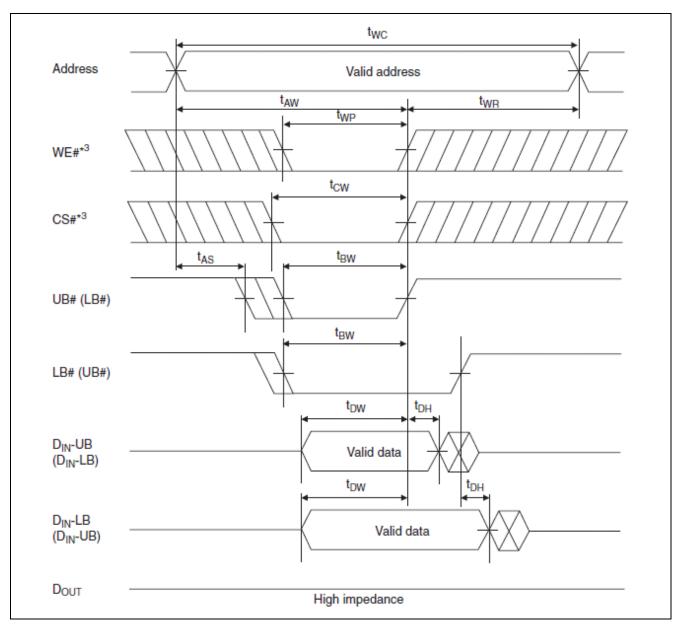
Write Timing Waveform (1) (WE# Controlled)



Write Timing Waveform (2) (CS# Controlled)



Write Timing Waveform (3) (LB#, UB# Controlled, OE# = V_{IH})



Revision History

		Description				
Rev.	Date	Page	Summary			
1.00	Nov.18.19	-	First Edition issued			

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